

# FDW264P

# P-Channel 2.5V Specified PowerTrench® MOSFET

### **General Description**

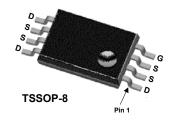
This P-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V-12V).

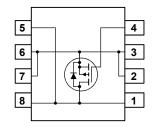
### **Applications**

- Load switch
- Motor drive
- DC/DC conversion
- Power management

### **Features**

- -9.7 A, -20 V.  $R_{DS(ON)}$  = 10.0 m $\Omega$  @  $V_{GS}$  = -4.5 V  $R_{DS(ON)}$  = 14.5 m $\Omega$  @  $V_{GS}$  = -2.5 V
- Extended V<sub>GSS</sub> range (±12V) for battery applications
- Low gate charge
- $\bullet \qquad \text{High performance trench technology for extremely} \\ \text{low $R_{\text{DS(ON)}}$}$
- Low profile TSSOP-8 package





## Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		± 12	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	-9.7	Α
	– Pulsed		-50	
P <sub>D</sub>	Power Dissipation	(Note 1a)	1.3	W
		(Note 1b)	0.6	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temp	erature Range	-55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	96	°C/W
		(Note 1b)	208	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
264P	FDW264P	13"	16mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics				•	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = –250 μA, Referenced to 25°C		-17		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V},  V_{GS} = 0 \text{ V}$			-1	μА
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V},  V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6	-0.9	-1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = –250 $\mu$ A, Referenced to 25°C		3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$ \begin{vmatrix} V_{GS} = -4.5 \text{ V}, & I_D = -9.7 \text{ A} \\ V_{GS} = -2.5 \text{ V}, & I_D = -8.4 \text{ A} \\ V_{GS} = -4.5 \text{ V}, I_D = -9.7 \text{ A}, T_J = 125^{\circ}\text{C} \\ \end{vmatrix} $		7.5 9.0 10.5	10 14.5	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-50			Α
<b>g</b> FS	Forward Transconductance	$V_{DS} = -10 \text{ V}, \qquad I_{D} = -9.7 \text{ A}$		71		S
Dynamic	: Characteristics					
C <sub>iss</sub>	Input Capacitance			7225		pF
Coss	Output Capacitance	$V_{DS} = -10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1030		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1.0 MHz		900		pF
$R_G$	Gate Resistance	V <sub>GS</sub> = 15mV, f = 1.0 MHz		10		Ω
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time			17	31	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A},$		17	31	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		480	770	ns
t <sub>f</sub>	Turn-Off Fall Time			265	422	ns
$Q_g$	Total Gate Charge			95	135	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{DS} = -10 \text{ V}, \qquad I_{D} = -9.7 \text{ A}, $ $V_{GS} = -5 \text{ V}$		13		nC
$Q_{gd}$	Gate-Drain Charge	V <sub>GS</sub> 5 V		24		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings		•	•	•
Is	Maximum Continuous Drain-Source				-1.1	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = -1.1 \text{ A}  \text{(Note 2)}$		-0.6	-1.2	V
T <sub>rr</sub>	Reverse Recovery Time	$I_F = -9.7 \text{ A},$		170		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$ (Note 3)		220		nC

### Notes:

- R<sub>0,JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface
  of the drain pins. R<sub>0,JC</sub> is guaranteed by design while R<sub>0,CA</sub> is determined by the user's board design.
  - a)  $R_{0JA}$  is  $96^{\circ}\text{C/W}$  (steady state) when mounted on a 1 inch² copper pad on FR-4. b)  $R_{0JA}$  is  $208^{\circ}\text{C/W}$  (steady state) when mounted on a minimum copper pad on FR-4.
- 2. Pulse Test: Pulse Width <  $300\mu s,$  Duty Cycle < 2.0%

# **Typical Characteristics**

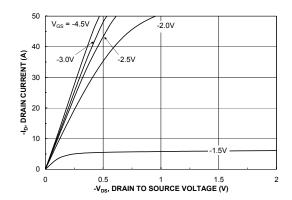


Figure 1. On-Region Characteristics.

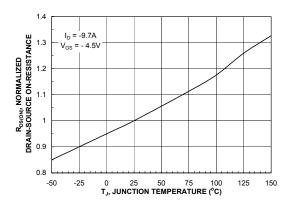


Figure 3. On-Resistance Variation with Temperature.

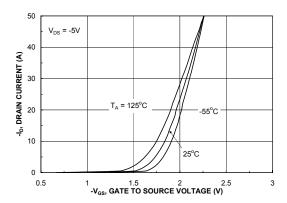


Figure 5. Transfer Characteristics.

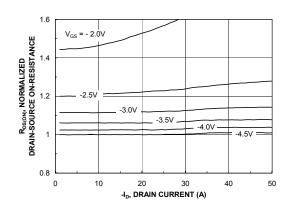


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

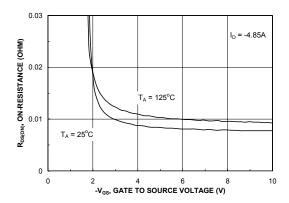


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

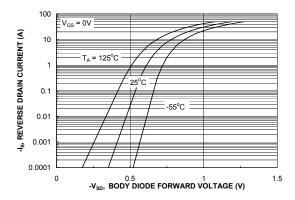
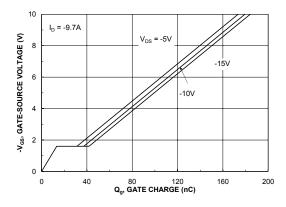


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



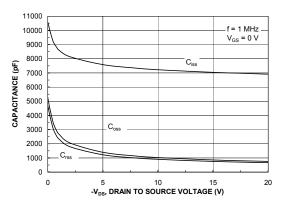


Figure 7. Gate Charge Characteristics.

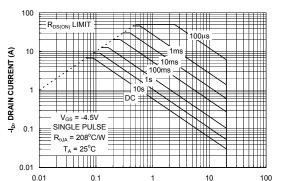


Figure 8. Capacitance Characteristics.

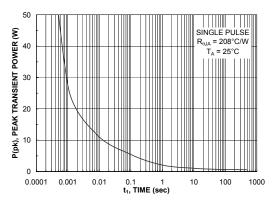


Figure 9. Maximum Safe Operating Area.

-V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V)



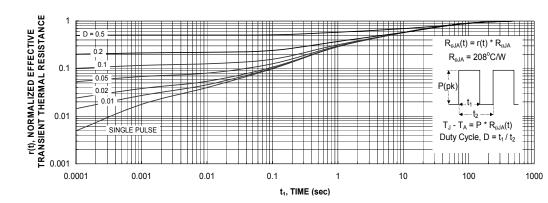


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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CROSSVOLT™	FRFET™	MicroPak™	QS™	SyncFET™
DOME™	GlobalOptoisolator™	MICROWIRE™	QT Optoelectronics™	TinyLogic <sup>®</sup>
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